Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,057	CHANG ET AL.	
Examiner	· Art Unit	
Brian S. Kwon	1614	

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	see search notes	11/19/2007	вк		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated (STN, EAST, NPL)	11/19/2007	ВК		
Updated (Continuity data, inventor name search)				
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